8NM60-FD Power MOSFET

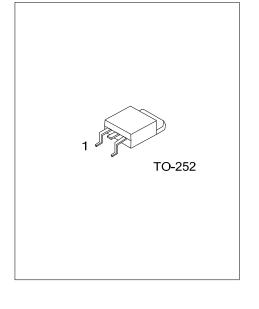
# 8A, 600V N-CHANNEL SUPER-JUNCTION MOSFET

#### DESCRIPTION

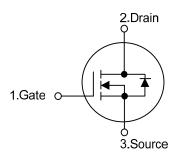
The **UTC 8NM60-FD** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

#### ■ FEATURES

- \*  $R_{DS(ON)}$  < 0.82  $\Omega$  @  $V_{GS}$  = 10V,  $I_{D}$  = 4.0A
- \* Fast Switching Capability
- \* Avalanche Energy Tested
- \* Improved dv/dt Capability, High Ruggedness



#### ■ SYMBOL



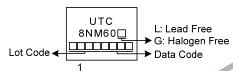
#### **■ ORDERING INFORMATION**

Ordering Number		Doolsono	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
8NM60L-TN3-R	8NM60G-TN3-R	TO-252	G	D	S	Tape Reel	

(3)Green Package

(3) G: Halogen Free and Lead Free, L: Lead Free

#### MARKING



8NM60-FD Power MOSFET

# ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	600	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Drain Current	Continuous	$I_{D}$	8	Α	
	Pulsed (Note 2)	$I_{DM}$	24	Α	
Avalanche Energy	valanche Energy Single Pulsed (Note 3)		80	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	6	V/ns	
Power Dissipation		$P_{D}$	62	W	
Junction Temperature		$T_J$	+150	°C	
Storage Temperature		$T_{STG}$	-55 ~ <b>+</b> 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=66mH,  $I_{AS}$ =1.55A,  $V_{DD}$ =2.3V,  $R_{G}$ =25  $\Omega$ , Starting  $T_{J}$  = 25°C
- 4.  $I_{SD} \le 8.0A$ , di/dt $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25$ °C

## **■ THERMAL DATA**

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	110	°C/W	
Junction to Case	$\theta_{JC}$	2	°C/W	

## ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> =25°C, unless otherwise specified)

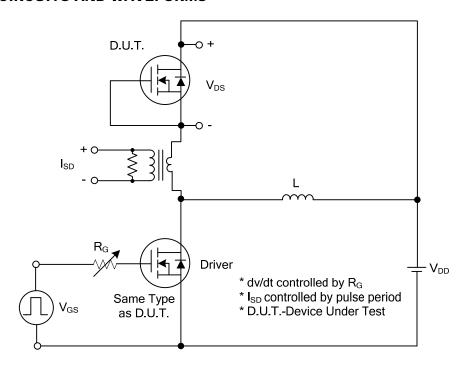
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	$V_{GS} = 0V, I_D = 250\mu A$	600			V	
Drain-Source Leakage Current		$I_{DSS}$	$V_{DS} = 600V, V_{GS} = 0V$			10	μΑ	
Gate- Source Leakage Current	Forward	I <sub>GSS</sub>	$V_{GS} = 30V, V_{DS} = 0V$			100	nA	
	Reverse		$V_{GS} = -30V, V_{DS} = 0V$			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$			4.5	V	
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.0A			0.82	Ω	
DYNAMIC CHARACTERISTICS								
Input Capacitance		C <sub>ISS</sub>			452		pF	
Output Capacitance		Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0 MHz		381		pF	
Reverse Transfer Capacitance		$C_{RSS}$	]		43		pF	
SWITCHING CHARACTERISTICS	6							
Total Gate Charge (Note 1)		$Q_G$	V <sub>DS</sub> =200V, V <sub>GS</sub> =10V, I <sub>D</sub> =8.0A,				nC	
Gate to Source Charge		$Q_GS$	$I_{G}$ =1mA (Note 1, 2)				nC	
Gate to Drain Charge		$Q_GD$	IG-IIIA (Note 1, 2)				nC	
Turn-ON Delay Time (Note 1)		t <sub>D(ON)</sub>	$V_{DD}$ =200V, $V_{GS}$ =10V, $I_{D}$ =8.0A, $I_{C}$ =8.0A (Note 1, 2)		6		ns	
Rise Time		$t_R$			20.8		ns	
Turn-OFF Delay Time		t <sub>D(OFF)</sub>			48		ns	
Fall-Time		$t_{\scriptscriptstyleF}$			37.2		ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		I <sub>S</sub>	A 112 C			8	Α	
Maximum Body-Diode Pulsed Current		$I_{SM}$	K (0)	*		24	Α	
Drain-Source Diode Forward Voltage (Note 1)		$V_{SD}$	I <sub>S</sub> =8.0A, V <sub>GS</sub> =0V			1.4	V	
Body Diode Reverse Recovery Time (Note 1)		t <sub>rr</sub>	I <sub>S</sub> =8.0A, V <sub>GS</sub> =0V,		156		ns	
Body Diode Reverse Recovery Charge		Qm	dl <sub>F</sub> /dt=100A/µs		0.97		μC	

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

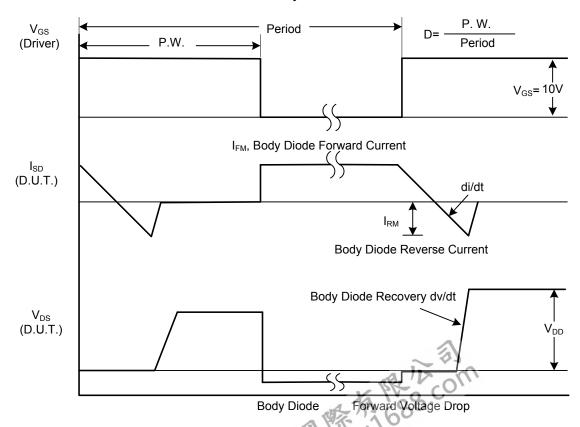
2. Essentially independent of operating temperature.

8NM60-FD Power MOSFET

## **■ TEST CIRCUITS AND WAVEFORMS**



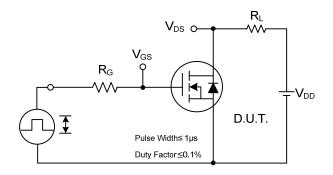
# Peak Diode Recovery dv/dt Test Circuit

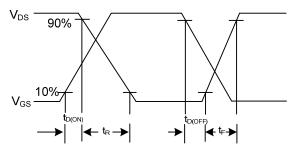


Peak Diode Recovery dw/dt Waveforms

8NM60-FD **Power MOSFET** 

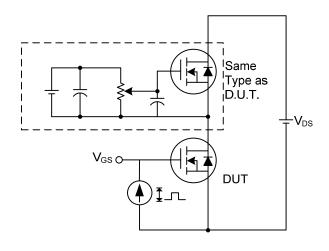
# **TEST CIRCUITS AND WAVEFORMS (Cont.)**

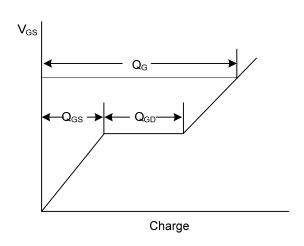




**Switching Test Circuit** 

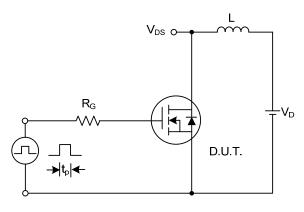
**Switching Waveforms** 

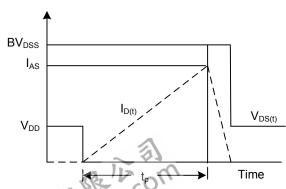




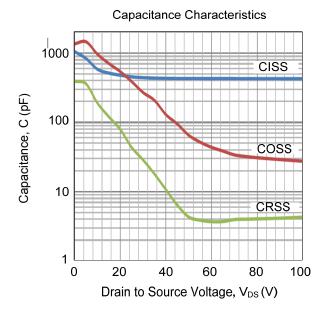
**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





## **■ TYPICAL CHARACTERISTICS**



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